

<b>Notice of References Cited</b>	Application/Control No. <b>10/084,935</b>	Applicant(s)/Patent Under Reexam <b>Yamazaki et al.</b>	
	Examiner <b>B. William Baumeister</b>	Art Unit <b>2815</b>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>
A	5,313,075 ✓	5/1994	Zhang et al.	257 57
B				
C				
D				
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F				
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K				
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M				

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	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>
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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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